

SRI 2024

Wednesday 28 August 2024

Mikrosymposium MS 12/1: Time Resolved Techniques: MS12/1 - Saal F (11:00 - 13:00)

time	[id] title	presenter
11:00	[936] X-ray cross-correlation analysis of crystalline defects using femtosecond X-ray pulses	MOELLER, Johannes
11:20	[830] Improving the Time-Resolution for Time Resolved Solution Phase Chemistry at XFELs	VAN DRIEL, Tim
11:40	[512] High-Throughput and High-Resolution Instrumentation for Time-Resolved Resonant Inelastic X-ray Scattering at SCS, European XFEL	SCHLAPPA, Justine
12:00	[174] Extended Time-Resolved Experimental Capabilities and Performance at the MAX IV FemtoMAX Beamline	KROON, David
12:15	[666] Speckle contrast from the split-and-delay unit with seeded X-ray pulses of the MID instrument at European XFEL	GOY, Claudia
12:30	[350] In Operando Observation for Dynamic Evolution of Pt Nanocatalysts in Pulsed Electrolysis	HUANG, Huan
12:45	[139] Sub-10nm Hard X-ray Transient Grating and its Application in Crystalline Samples	LI, Haoyuan